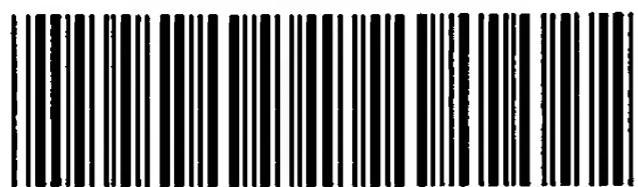


Search Notes



Application/Control No.

10/611,692

Examiner

Jason M. Han

**Applicant(s)/Patent under
Reexamination**

JACOBS ET AL.

Art Unit

2875

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)